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Application/Control No.	Applicant(s)/Patent under Reexamination
10/046,300	MATSUURA, SYUUJI
Examiner	Art Unit
Christopher M. Lambrecht	2611

	SEAR	CHED	
Class	Subclass	Date	Examiner
725	111 151	6/24/2005	CML
Updated	-	12/20/2005	CML

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEAF (INCLUDING S	RCH NOTES EARCH STRATEGY)
	DATE	EXMR
EAST	6/24/2005	CML
NPL	6/24/2005	CML
EAST	12/20/2005	CML